





Application/Control No.	Applicant(s)/Patent under Reexamination
10/534,847	FERNANDEZ MATEU ET AL.
Examiner	Art Unit
Khoa D. Huynh	3751

	SEAR	CHED	
Class	Subclass	Date	Examiner
004	245.1- 245.9, 244.1- 244.3, 235	4/1/2006	нк
004	237,239		
004	901,571.1		
004	572.1		
004	243.1		
004	243.2		
004	243.3		
updated	all above	7/7/2006	нк
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INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST text search, see print out	4/2/2006	HK		
interference search, see print out	7/7/2006	нк		
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